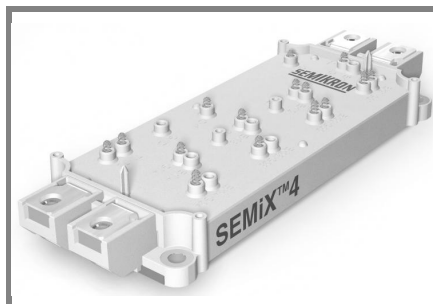


SEMiX 604GB176HDs



SEMiX® 4s

Trench IGBT Modules

SEMiX 604GB176HDs

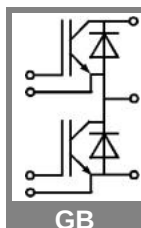
Target Data

Features

- Homogeneous Si
- Trench = Trenchgate technology
- $V_{CE(sat)}$ with positive temperature coefficient
- High short circuit capability

Typical Applications

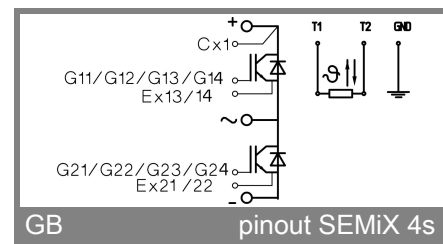
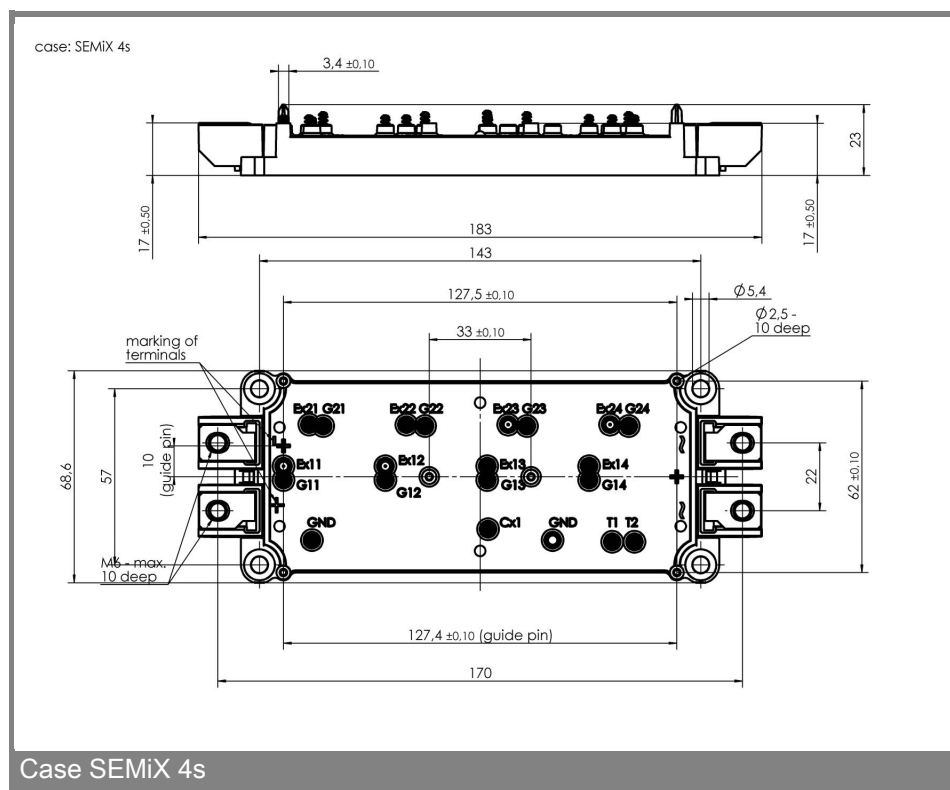
- AC inverter drives
- UPS
- Electronic welders



Absolute Maximum Ratings		$T_c = 25\text{ °C}$, unless otherwise specified	
Symbol	Conditions	Values	Units
IGBT			
V_{CES}		1700	V
I_C	$T_c = 25\text{ (80) °C}$	600 (430)	A
I_{CRM}	$t_p = 1\text{ ms}$	800	A
V_{GES}		± 20	V
T_{vj} , (T_{stg})	$T_{OPERATION} \leq T_{stg}$	- 40 ... + 150 (125)	°C
V_{isol}	AC, 1 min.	4000	V
Inverse diode			
I_F	$T_c = 25\text{ (80) °C}$	550 (370)	A
I_{FRM}	$t_p = 1\text{ ms}$	800	A
I_{FSM}	$t_p = 10\text{ ms}$; sin.; $T_j = 25\text{ °C}$	3800	A

Characteristics		$T_c = 25\text{ °C}$, unless otherwise specified			
Symbol	Conditions	min.	typ.	max.	Units
IGBT					
$V_{GE(th)}$	$V_{GE} = V_{CE}$, $I_C = 16\text{ mA}$	5,2	5,8	6,4	V
I_{CES}	$V_{GE} = 0$, $V_{CE} = V_{CES}$, $T_j = 25\text{ (125) °C}$			2,4	mA
$V_{CE(TO)}$	$T_j = 25\text{ (125) °C}$		1 (0,9)	1,2 (1,1)	V
r_{CE}	$V_{GE} = 0\text{ V}$, $T_j = 25\text{ (125) °C}$		2,5 (3,9)	3,1 (4,5)	mΩ
$V_{CE(sat)}$	$I_{Cnom} = 400\text{ A}$, $V_{GE} = 15\text{ V}$, $T_j = 25\text{ (125) °C}$, chip level		2 (2,45)	2,45 (2,9)	V
C_{ies}	under following conditions		28,4		nF
C_{oes}	$V_{GE} = 0$, $V_{CE} = 25\text{ V}$, $f = 1\text{ MHz}$		1,5		nF
C_{res}			1,2		nF
L_{CE}			22		nH
$R_{CC'+EE'}$	terminal-chip, $T_c = 25\text{ (125) °C}$				mΩ
$t_{d(on)}/t_r$	$V_{CC} = 1200\text{ V}$, $I_{Cnom} = 400\text{ A}$				ns
$t_{d(off)}/t_f$	$V_{GE} = \pm 15\text{ V}$				ns
E_{on} (E_{off})	$R_{Gon} = R_{Goff} = \Omega$, $T_j = 125\text{ °C}$		240 (140)		mJ
Inverse diode					
$V_F = V_{EC}$	$I_{Fnom} = 400\text{ A}$; $V_{GE} = 0\text{ V}$; $T_j = 25\text{ (125) °C}$, chip level		1,7 (1,7)	1,9 (1,9)	V
$V_{(TO)}$	$T_j = 25\text{ (125) °C}$		1,1 (0,9)	1,3 (1,1)	V
r_T	$T_j = 25\text{ (125) °C}$		1,5 (2)	1,5 (2)	mΩ
I_{RRM}	$I_{Fnom} = 400\text{ A}$; $T_j = 25\text{ (125) °C}$				A
Q_{rr}	$di/dt = A/\mu s$				μC
E_{rr}	$V_{GE} = -15\text{ V}$				mJ
Thermal characteristics					
$R_{th(j-c)}$	per IGBT			0,051	K/W
$R_{th(j-c)D}$	per Inverse Diode			0,09	K/W
$R_{th(j-c)FD}$	per FWD				K/W
$R_{th(c-s)}$	per module		0,03		K/W
Temperature sensor					
R_{25}	$T_c = 25\text{ °C}$		5 $\pm$ 5%		kΩ
$B_{25/85}$	$R_2 = R_1 \exp[B(1/T_2 - 1/T_1)]$; $T[K]; B$		3420		K
Mechanical data					
M_s/M_t	to heatsink (M5) / for terminals (M6)	3/2,5		5 / 5	Nm
w			390		g

SEMiX 604GB176HDs



This is an electrostatic discharge sensitive device (ESDS), international standard IEC 60747-1, Chapter IX.

This technical information specifies semiconductor devices but promises no characteristics. No warranty or guarantee expressed or implied is made regarding delivery, performance or suitability.